

Search Notes

Application/Control No.

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Examiner

Jung Park

Applicant(s)/Patent under
Reexamination

KHILL, UZI

Art Unit

2661

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Consulted with Chau Nguyen, Christian Laforgia, & Andrew Caldwell 370/401-404, 707/1 (text search only - see history printout	12/27/2005	JP
EAST (USPT, US_PGPUB) - See Search History Printout	12/27/2005	JP
Internet Search for IEEE Standard	12/27/2005	JP
370/401-404; 707/1 (text search only - see history printout	5/1/2006	JP